

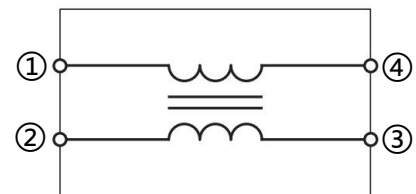
## Desicription

- ◆ The common mode filter is mainly used to reduce radiation and high frequency common mode noise.
- ◆ Reduce asymmetric interference on data lines and other interfaces.
- ◆ Impedance characteristics match the impedance of most differential interface Settings, controlling unnecessary reflection formation
- ◆ Low leakage, no effect on differential mode current.



## Features

- ◆ Size:1.25mm\*1.0mm\*0.5mm
- ◆ Halogen free ,Lead free ,Reach and RoHs
- ◆ USB3.0 ,HDMI,MIPI,DP,LVDS.



**Circuit Diagram**

## Application

- ◆ Cellular phones
- ◆ Portable devices
- ◆ Digital cameras
- ◆ Player
- ◆ Smart home
- ◆ Robot

PIN NUMBER	DESCRIPTION
① ~ ④	DATE LINE
② ~ ③	DATE LINE

## Order information

Model	Package	shipping
CMF1210UD101MST	1210	4000/Tape&Reel

## Part Numbering

<b>CMF</b>	<b>1210</b>	<b>UD</b>	<b>101</b>	<b>M</b>	<b>S</b>	<b>T</b>
A	B	C	D	E	F	G

A:ASIM common mode filter

B:Dimension

C:Cut-off frequency (6 GHz Typ)

D:Common Mode Impedance (at 100MHz), 101= 100Ω

E:Tolerance of common mode impedance, M= ±20%

F:Laminated sintering process.

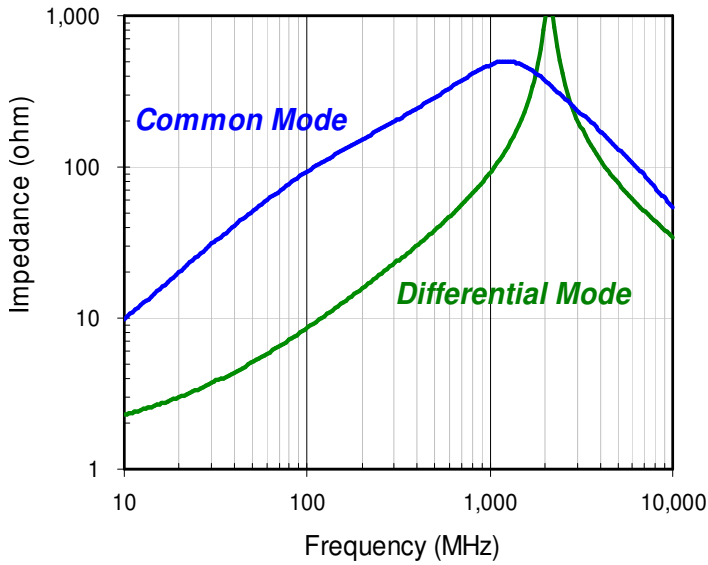
G:Packing Type

## Specification

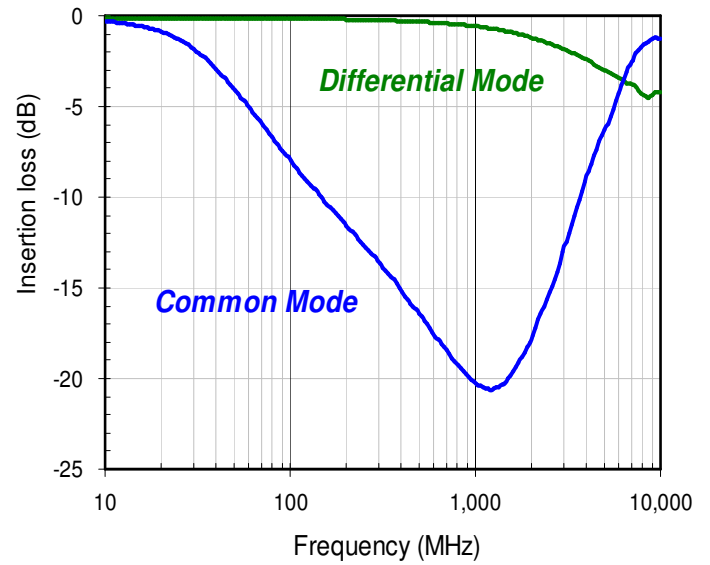
Part number	Common mode impedance(Ω) @100MHz	Rated Current (mA)	DC Resistance (Ω)	
			TYP	MAX
<b>CMF1210UD101MST</b>	100±20%	130	1.5	3
	<b>Rated volt (Vdc)</b>	<b>Withstand volt (Vdc)</b>	<b>IR (Ω) min</b>	
	5	12.5	10M	
	<b>Operation junction temperature</b>	<b>Lead temperature</b>	<b>Storage temperature*</b>	
	-40℃~+85℃	260℃	-40℃~85℃	

\*The storage temperature is subject to the fixed substrate

## Typical Electrical Characteristic

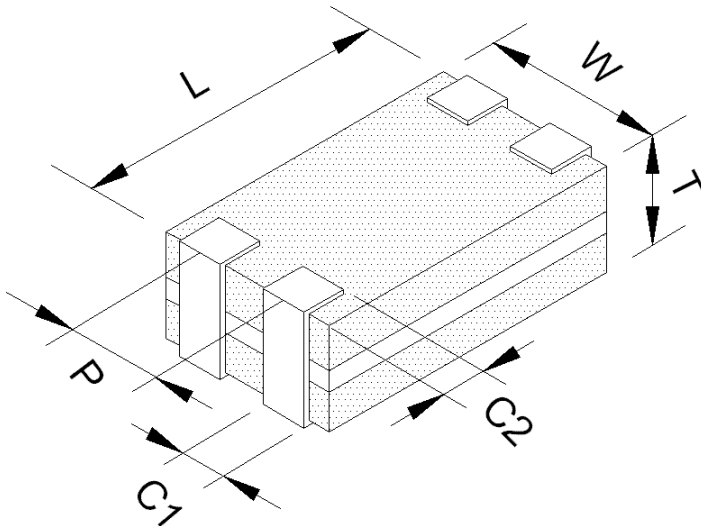


**Impedance VS Frequency**



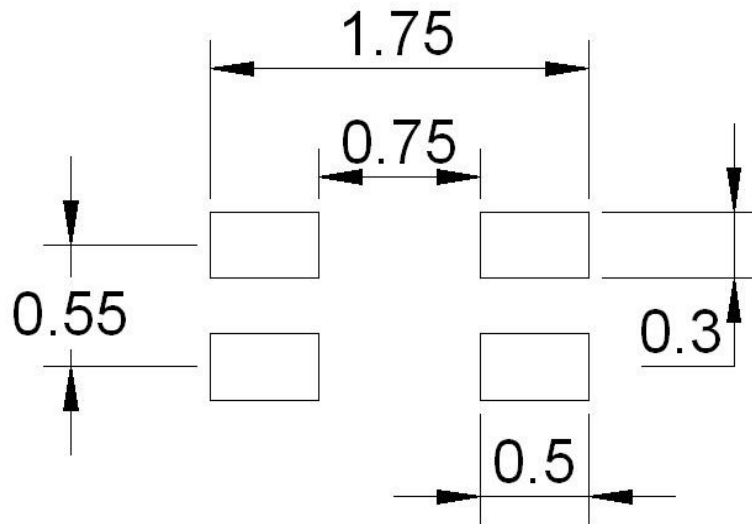
**Insertion loss VS Frequency**

## Dimension (mm)

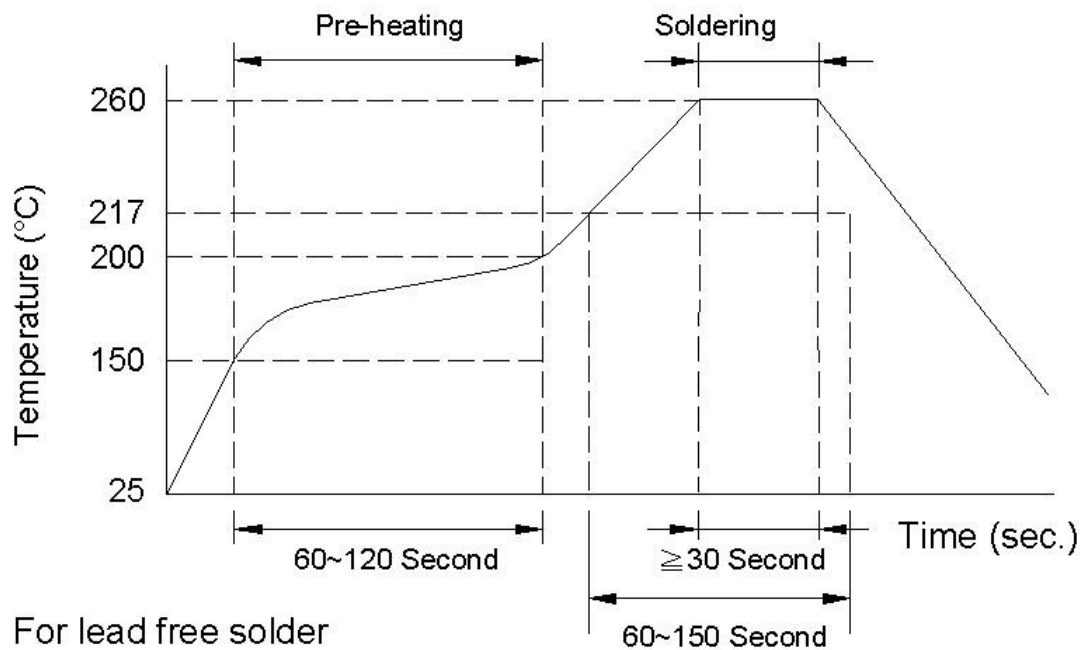


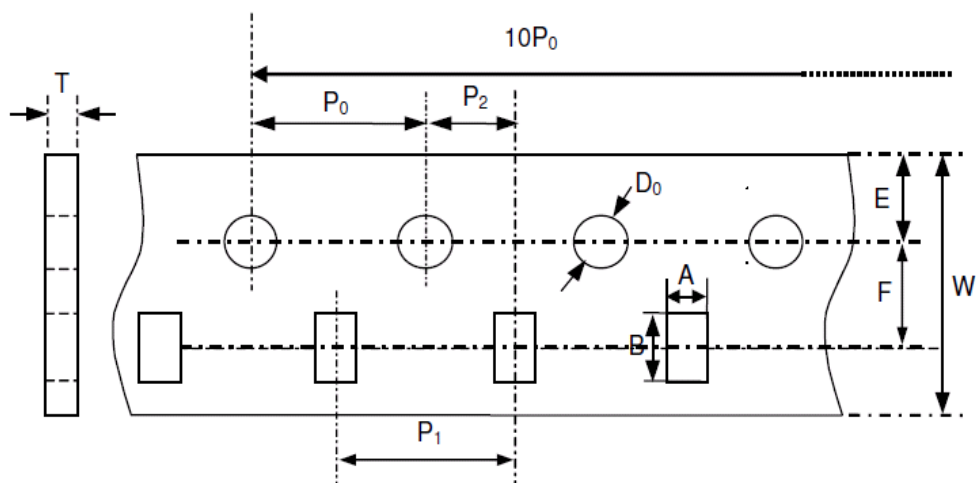
TYPE	Dimension
L	1.25±0.10
W	1.00±0.10
T	0.50±0.10
P	0.55±0.10
C1	0.30±0.10
C2	0.20±0.15
Unit : mm	

### Recommended Land Pattern (mm)

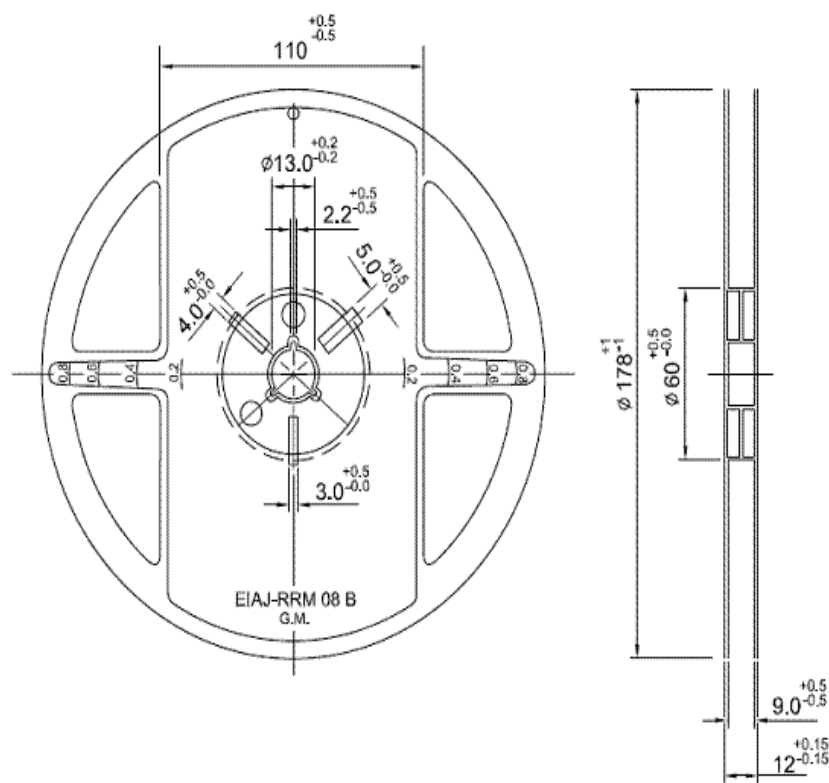


### Recommended Reflow Profile



**Tape and reel specification/Taping dimensions (mm)**


Symbol	Size	Symbol	Size
A	$1.20 \pm 0.05$	$P_0$	$4.00 \pm 0.10$
B	$1.45 \pm 0.05$	$P_1$	$4.00 \pm 0.10$
W	$8.00 \pm 0.10$	$P_2$	$2.00 \pm 0.05$
E	$1.75 \pm 0.05$	$D_0$	$1.55 \pm 0.05$
F	$3.50 \pm 0.05$	T	$0.60 \pm 0.03$



## Reliability and test condition

Test item	Test condition	Criteria
<b>Temperature Cycle</b>	A. Temperature : -40 ~ +85℃ B. Cycle : 100 cycles C. Dwell time : 30minutes Measurement : at ambient temperature 24 hrs after test completion	A. No mechanical damage B. Impedance value should be within $\pm 20\%$ of the initial value
<b>Operational Life</b>	A. Temperature : 85℃ $\pm 5^\circ\text{C}$ B. Test time : 1000 hrs C. Apply current : full rated current Measurement : at ambient temperature 24 hrs after test completion	A. No mechanical damage B. Impedance value should be within $\pm 20\%$ of the initial value
<b>Biased Humidity</b>	A. Temperature : 40 $\pm 2^\circ\text{C}$ B. Humidity : 90 ~ 95 % RH C. Test time : 1000 hrs D. Apply current : full rated current Measurement : at ambient temperature 24 hrs after test completion	A. No mechanical damage B. Impedance value should be within $\pm 20\%$ of the initial value
<b>Resistance to Solder Heat</b>	A. Solder temperature : 260 $\pm 5^\circ\text{C}$ B. Flux : Rosin C. DIP time : 10 $\pm 1$ sec	A. More than 95 % of terminal electrode should be covered with new solder B. No mechanical damage C. Impedance value should be within $\pm 20\%$ of the initial value
<b>Steam Aging Test</b>	A. Temperature : 93 $\pm 2^\circ\text{C}$ B. Test time : 4 hrs C. Solder temperature : 235 $\pm 5^\circ\text{C}$ D. Flux : Rosin E. DIP time : 5 $\pm 1$ sec	More than 95 % of terminal electrode should be covered with new solder